|  |  |  |  |
| --- | --- | --- | --- |
| QUALIFICATION PLAN #10524 | | | |
| Test | Specification | Sample Size | Expected Completion Date |
| High Temperature Operating Life (HTOL)\* | JEDEC*JESD22-A108* | **1\*77** | **Nov 2013** |
| **1\*77** | **Nov 2013** |
| Early Life Failure (ELF) | MIL-STD-883, *Method 1015* | **3\*667** | **Nov 2013** |
| High Temperature Storage Life (HTSL) | JEDEC *JESD22-A103* | **1\*45** | **Oct 2013** |
| **1\*45** | **Oct 2013** |
| Latch-Up | JEDEC *JESD78* | **6** | **Oct 2013** |
| **6** | **Oct 2013** |
| Electrostatic Discharge  *Human Body Model* | ESDA/JEDEC *JDS-001-2011* | **3/voltage** | **Oct 2013** |
| **3/voltage** | **Oct 2013** |
| Electrostatic Discharge  *Field-Induced Charged Device Model* | JEDEC*JESD22-C101* | **3/voltage** | **Oct 2013** |
| **3/voltage** | **Oct 2013** |
| Electrostatic Discharge  *Machine Model* | JEDEC*JESD22-A115* | **3/voltage** | **Oct 2013** |
| **3/voltage** | **Oct 2013** |
| Electrostatic Discharge  *15kV IEC HBM* | IEC *6100-4-2* | **3/voltage** | **Nov 2013** |
| **3/voltage** |

\*Preconditioned per JEDEC/IPC J-STD-020